Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/826,148	SCHIPPL, KLAUS	
Examiner	Art Unit	
Donahai D. Nauven	3729	

SEARCHED			
Class	Subclass	Date	Examiner
29	33 B, 33 D 33 T, 599 745	9/7/2006	DN
	868-871		
138	113		
174	15.5		
	75 R		
	125.1		
	126.3		
505	230-234		1
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East Search Updated (see attached)	9/7/2006	b√